

Search Notes

Application/Control No.

10/586,287

Examiner

RIP A. LEE

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

1796

SEARCHED

Class	Subclass	Date	Examiner
556	143	6/3/2009	RL
556	144	6/3/2009	RL
556	145	6/3/2009	RL
556	138	6/3/2009	RL
556	140	6/3/2009	RL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/3/2009	RL
palm -inventor search	6/3/2009	RL
STN - structure search	6/3/2009	RL